Product Preview

Power MOSFET

-30 V, Single P-Channel, WDFN6

Features

- Small Footprint (4 mm²) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- These Devices are Pb–Free, Halogen–Free/BFR–Free and are RoHS Compliant

Applications

- Battery Management
- Protection
- Power Load Switch

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	-30	V
Gate-to-Source Voltage			V_{GS}	±25	V
Continuous Drain Cur-	Steady	T _A = 25°C	I _D	-11.7	Α
rent R _{θJA} (Notes 1, 3)	State	T _A = 85°C		-8.4	
Power Dissipation R _{θJA} (Notes 1, 3)		T _A = 25°C	P _D	2.40	W
Continuous Drain Cur-	Steady	T _A = 25°C	I _D	-7.0	Α
rent R _{θJA} (Notes 2, 3)	State T _A = 85°C			-5.1	
Power Dissipation R _{θJA} (Notes 2, 3)		T _A = 25°C	P _D	0.86	W
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \mu s$		I _{DM}	47	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to +150	°C
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	52	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

- 1. Surface-mounted on FR4 board using 1 $\rm in^2$ pad size, 2 oz. Cu pad.
- 2. Surface-mounted on FR4 board using minimum pad size, 2 oz. Cu pad.
- 3. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted. Actual continuous current will be limited by thermal & electro–mechanical application board design. $R_{\theta CA}$ is determined by the user's board design.

This document contains information on a product under development. ON Semiconductor reserves the right to change or discontinue this product without notice.

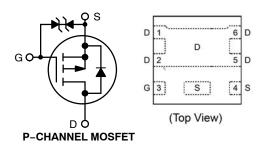


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
-30 V	11.3 mΩ @ –10 V	–11.7 A
	21.3 mΩ @ -4.5 V	-11.7 A

ELECTRICAL CONNECTION





WDFN6 (2.05x2.05) CASE 483AV

MARKING DIAGRAM



YW = Date Code

ZZ = Assembly Lot Code

A = Assembly Site Code

XXX = Specific Device Code

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 3 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Cond	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS		•					•
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = -250 μA		-30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /	I _D = -250 μA, ref to 25°C			13.1		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -24 \text{ V}$ $T_{J} = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$	T _J = 25°C			-1	μΑ
		$V_{DS} = -24 \text{ V}$	T _J = 125°C			-10	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{G}$				±10	μΑ
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	-1.0		-3.0	V
Threshold Temperature Coefficient	V _{GS} /T _J	I _D = -250 μA, ι	ef to 25°C		-6.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = −10 V, I	_D = -10 A		8.1	11.3	mΩ
		$V_{GS} = -4.5 \text{ V},$	I _D = -10 A		17	21.3	
Forward Transconductance	9FS	V _{DS} = -5 V, I _I	₀ = -10 A		34		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}				1500		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} f = 1.0 N			530		
Reverse Transfer Capacitance	C _{rss}	1 = 1.5 K	11 12		495		
Total Gate Charge	Q _{G(TOT)}				25		nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = -4.5 V. V	ne = -15 V.		3.0		nC
Gate-to-Source Charge	Q _{GS}	$V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V},$ $I_{D} = -10 \text{ A}$			16		1
Gate-to-Drain Charge	Q_{GD}				4.5		
Total Gate Charge	Q _{G(TOT)}	$V_{GS} = -10 \text{ V}, V_{I}$ $I_{D} = -10 \text{ V}$	_{OS} = -15 V, O A		41		nC
SWITCHING CHARACTERISTICS, V	GS = 4.5 V (Note	e 5)					•
Turn-On Delay Time	t _{d(on)}				20		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _I	nn = -15 V.		157		1
Turn-Off Delay Time	t _{d(off)}	I _D = -10 A, F			38		
Fall Time	t _f	1			67		
SWITCHING CHARACTERISTICS, V	GS = 10 V (Note	5)					
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	Vos = -10 V. Vr	nn = -15 V.		29		-
Turn-Off Delay Time	t _{d(off)}	$V_{GS} = -10 \text{ V}, V_{DD} = -15 \text{ V},$ $I_{D} = -10 \text{ A}, R_{G} = 6 \Omega$			87		
Fall Time	t _f				65		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V_{SD}	V _{GS} = 0 V,	T _J = 25°C		0.83	1.3	V
-	35	$I_{S} = -10 \text{ A}$	T _J = 125°C		0.7		1
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dI _S /dt = -100 A/ μ s, I _S = -10 A			31		ns
Reverse Recovery Charge	Q _{RR}				10		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.

5. Switching characteristics are independent of operating junction temperatures.

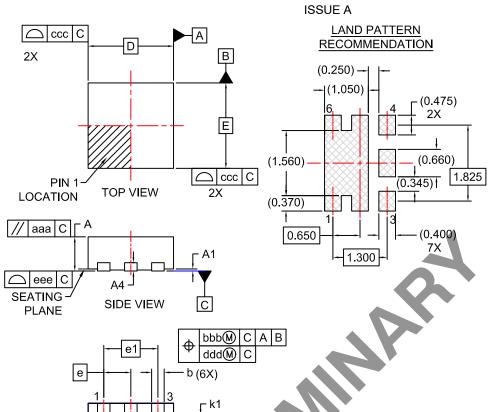
DEVICE ORDERING INFORMATION

Device	Package	Shipping [†]
NTLJS17D0P03P8ZTAG	WDFN6 (Pb-Free)	3000 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

WDFN6 2.05X2.05, 0.65P CASE 483AV



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETERS.
- 2. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS.
- 4. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM	MILLIMETERS			
51	MIN.	NOM.	MAX.	
Α	0.60	0.70	0.80	
A1	0.00	-	0.05	
A4		(0.20)		
b	0.25	0.30	0.35	
D	1.95	2.05	2.15	
D2	0.84	0.89	0.94	
D3		(0.95)		
Е	1.95	2.05	2.15	
E2	1.45	1.50	1.55	
е	0.65 BSC			
e1	1.30 BSC			
k	(0.35)			
k1	(0.45)			
L	0.18	0.28	0.38	
L3	0.25	0.30	0.35	
L4	0.55	0.60	0.65	
L5	(0.23)			
aaa	0.10			
bbb	0.10			
ccc	0.05			
ddd	0.05			
eee	0.05			

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